

<b>Notice of References Cited</b>	Application/Control No. 10/825,756	Applicant(s)/Patent Under Reexamination OUESLATI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0196790 A1	10-2004	Balakrishnan et al.	370/232
*	B	US-2004/0151197 A1	08-2004	Hui, Ronald Chi-Chun	370/412
*	C	US-2004/0008716 A1	01-2004	Stiliadis, Dimitrios	370/429
*	D	US-2003/0014180 A1	01-2003	Myr, David	701/117
*	E	US-2002/0150047 A1	10-2002	Knight et al.	370/230.1
*	F	US-7,126,918 B2	10-2006	Roberts, Lawrence G.	370/235
*	G	US-7,061,861 B1	06-2006	Mekkittikul et al.	370/230
*	H	US-7,002,918 B1	02-2006	Prieto et al.	370/252
*	I	US-6,643,256 B1	11-2003	Shimojo et al.	370/229
*	J	US-5,633,859 A	05-1997	Jain et al.	370/234
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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